Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/663,698	CHANG ET AL.	
Examiner	Art Unit	
B. Chen	1762	

SEARCHED			
Class	Subclass	Date	Examiner
•			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
			:		
		<u>-</u>			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST	10/31/2005	ВС
discussed art rejection w/ SPE Meeks		
		•